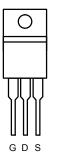


CMP40N20B-VB Datasheet

N-Channel 200 V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|--------------------------------|--------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) | | |
| 200 | 0.058at V _{GS} = 10 V | 35 | | |

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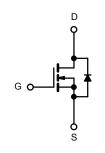


FEATURES

- TrenchFET[®] Power MOSFETS
- 175 °C Junction Temperature
- New Low Thermal Resistance Package
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

Industrial



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | | |
|--|-------------------------------------|-----------------------------------|------------------|-----|--|--|
| Parameter | Symbol | Limit | Unit | | | |
| Drain-Source Voltage | V _{DS} | 200 | V | | | |
| Gate-Source Voltage | V _{GS} | ± 20 | v | | | |
| Continuous Drain Current (T ₁ = 175 °C) | T _C = 25 °C | | 35 | | | |
| Continuous Drain Current (1j = 175°C) | T _C = 125 °C | I _D | 23 | • | | |
| Pulsed Drain Current | I _{DM} | 70 | - A | | | |
| Avalanche Current | I _{AR} | 35 | | | | |
| Repetitive Avalanche Energy ^a | L = 0.1 mH | E _{AR} | 61 | mJ | | |
| | T _C = 25 °C | D | 300 ^b | 14/ | | |
| Maximum Power Dissipation ^a | T _A = 25 °C ^c | – P _D – | 3.75 | - W | | |
| Operating Junction and Storage Temperature Ra | ange | T _J , T _{stg} | - 55 to 175 | °C | | |

| THERMAL RESISTANCE RATINGS | | | | | |
|--|-------------------|-------|------|--|--|
| Parameter | Symbol | Limit | Unit | | |
| Junction-to-Ambient (PCB Mount) ^c | R _{thJA} | 40 | °C/W | | |
| Junction-to-Case (Drain) | R _{thJC} | 0.5 | C/W | | |

Notes:

a. Duty cycle \leq 1 %.

b. See SOA curve for voltage derating.

c. When mounted on 1" square PCB (FR-4 material).

| SPECIFICATIONS ($T_J = 25$ | °C, unless o | otherwise noted) | | | | | |
|---|----------------------|--|----------|----------|-------|------|--|
| Parameter | Symbol | Test Conditions | Min . | Тур. | Max. | Unit | |
| Static | | - | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{DS} = 0 V, I_{D} = 250 \mu A$ | 200 | | | V | |
| Gate Threshold Voltage | V _{GS(th)} | V_{DS} = V_{GS} , I_D = 250 μ A | 2 | | 4 | v | |
| Gate-Body Leakage | I _{GSS} | V_{DS} = 0 V, V_{GS} = ± 30 V | | | ± 250 | nA | |
| | | V _{DS} = 200 V, V _{GS} = 0 V | | | 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 125 °C | | | 50 | μA | |
| | | V _{DS} = 200 V, V _{GS} = 0 V, T _J = 175 °C | | | 250 | 1 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 V$, V_{GS} = 10 V | 70 | | | А | |
| | | V _{GS} = 10 V, I _D = 20 A | | 0.058 | | - Ω | |
| | Р | V _{GS} = 10 V, I _D = 20 A, T _J = 125 °C | | 0.130 | | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = 10 V, I _D = 20 A, T _J = 175 °C | | 0.170 | | | |
| | | V _{GS} = 6 V, I _D = 15 A | | 0.070 | | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 15 V, I _D = 20 A | | 70 | | S | |
| Dynamic ^b | - | | <u>.</u> | ! | | | |
| Input Capacitance | C _{iss} | | | 2690 | | pF | |
| Output Capacitance | C _{oss} | V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz | | 200 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 110 | | | |
| Total Gate Charge ^c | Qg | | | 95 | 140 | nC | |
| Gate-Source Charge ^c | Q _{gs} | V_{DS} = 100 V, V_{GS} = 10 V, I_{D} = 45 A | | 28 | | | |
| Gate-Drain Charge ^c | Q _{gd} | | | 34 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 1.6 | | Ω | |
| Turn-On Delay Time ^c | t _{d(on)} | | | 22 | 35 | | |
| Rise Time ^c | tr | V _{DD} = 100 V, R _L = 2.78 Ω | | 220 | 330 | ns | |
| Turn-Off Delay Time ^c | t _{d(off)} | $I_D \cong 45 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 2.5 \Omega$ | | 40 | 60 | | |
| Fall Time ^c | t _f | | | 145 | 220 | | |
| Source-Drain Diode Ratings and Cha | aracteristics (| $T_{\rm C} = 25 ^{\circ}{\rm C})^{\rm b}$ | <u> </u> | | | | |
| Continuous Current | ۱ _S | | | | 45 | ^ | |
| Pulsed Current | I _{SM} | | | | 70 | A | |
| Forward Voltage ^a | V _{SD} | I _F = 45 A, V _{GS} = 0 V | | 1 | 1.5 | V | |
| Reverse Recovery Time | t _{rr} | | | 150 | 225 | ns | |
| Peak Reverse Recovery Current | I _{RM(REC)} | I _F = 45 A, di/dt = 100 A/μs | | 12 | 18 | А | |
| Reverse Recovery Charge | Q _{rr} | 1 | | 0.9 | 2 | μC | |

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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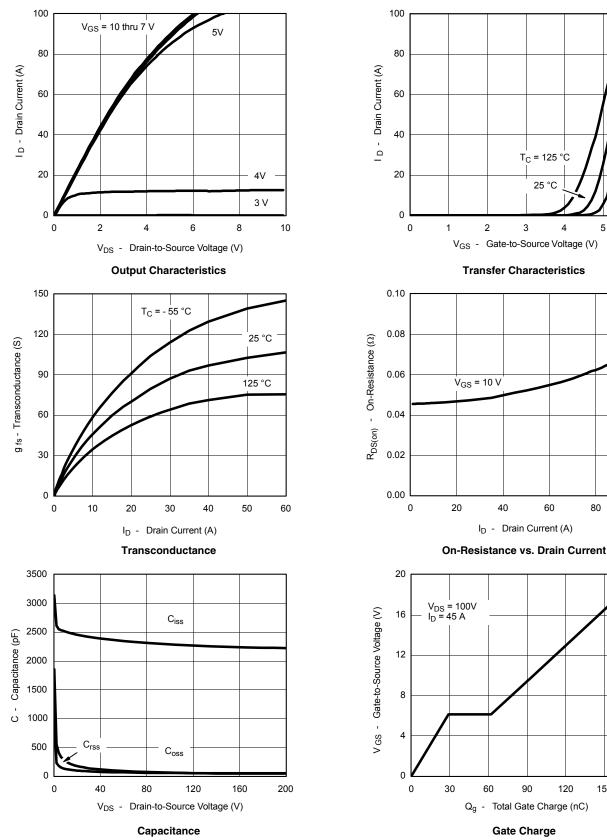
- 55 °C

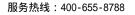
T_C = 125 °C

25 °C

Gate Charge



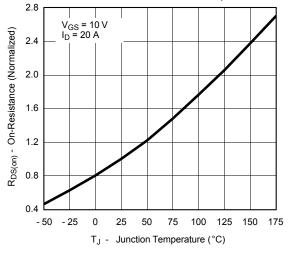




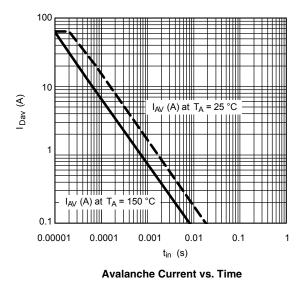
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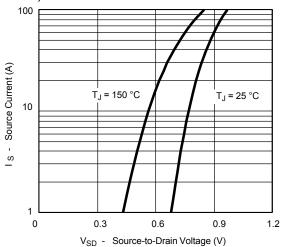


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

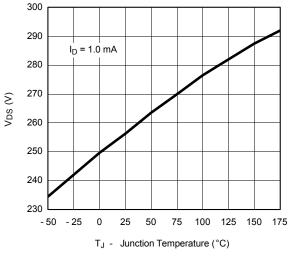


On-Resistance vs. Junction Temperature





Source-Drain Diode Forward Voltage

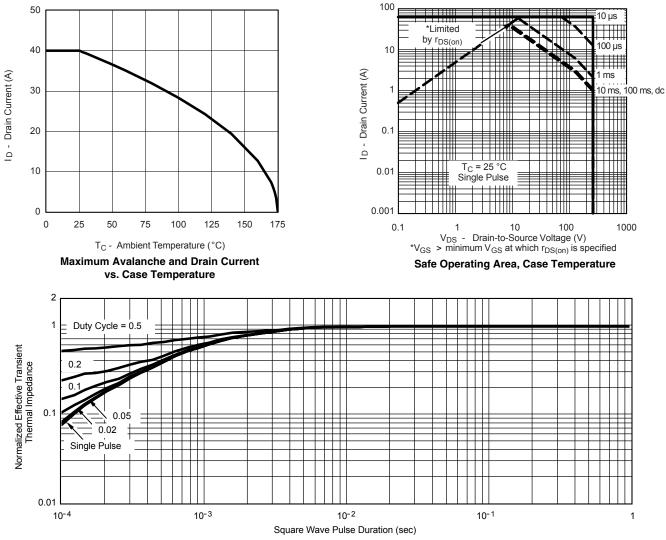


Drain Source Breakdown vs. Junction Temperature

CMP40N20B-VB



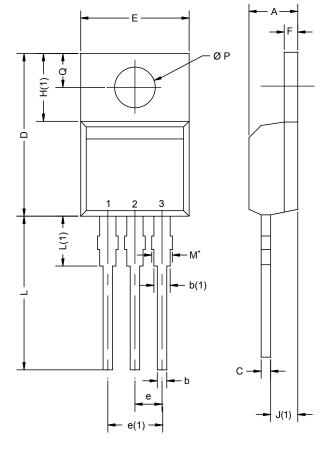
THERMAL RATINGS



Normalized Thermal Transient Impedance, Junction-to-Case



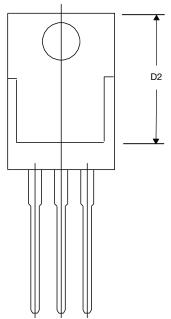
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| | MILLIN | IETERS | INC | HES | | |
|------|--|--------|-------|-------|--|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | | |
| А | 4.25 | 4.65 | 0.167 | 0.183 | | |
| b | 0.69 | 1.01 | 0.027 | 0.040 | | |
| b(1) | 1.20 | 1.73 | 0.047 | 0.068 | | |
| с | 0.36 | 0.61 | 0.014 | 0.024 | | |
| D | 14.85 | 15.49 | 0.585 | 0.610 | | |
| D2 | 12.19 | 12.70 | 0.480 | 0.500 | | |
| E | 10.04 | 10.51 | 0.395 | 0.414 | | |
| е | 2.41 | 2.67 | 0.095 | 0.105 | | |
| e(1) | 4.88 | 5.28 | 0.192 | 0.208 | | |
| F | 1.14 | 1.40 | 0.045 | 0.055 | | |
| H(1) | 6.09 | 6.48 | 0.240 | 0.255 | | |
| J(1) | 2.41 | 2.92 | 0.095 | 0.115 | | |
| L | 13.35 | 14.02 | 0.526 | 0.552 | | |
| L(1) | 3.32 | 3.82 | 0.131 | 0.150 | | |
| ØP | 3.54 | 3.94 | 0.139 | 0.155 | | |
| Q | 2.60 | 3.00 | 0.102 | 0.118 | | |
| | ECN: T14-0413-Rev. P, 16-Jun-14 DWG: 5471 | | | | | |

Note

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM





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